

<b>Notice of References Cited</b>		Application/Control No. 09/696,177	Applicant(s)/Patent Under Reexamination MCCREESH ET AL.	
		Examiner Backhean Tiv	Art Unit 2151	Page 1 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,675,510 A	10-1997	Coffey et al.	709/224
	B	US-5,949,415 A	09-1999	Lin et al.	715/740
	C	US-5,991,814 A	11-1999	Rzonca et al.	709/237
	D	US-6,026,427 A	02-2000	Nishihara et al.	718/106
	E	US-6,112,237 A	08-2000	Donaldson et al.	709/224
	F	US-6,222,529 B1	04-2001	Ouatu-Lascar et al.	715/745
	G	US-6,240,452 B1	05-2001	Welch et al.	709/224
	H	US-6,282,701 B1	08-2001	Wygodny et al.	717/125
	I	US-6,351,777 B1	02-2002	Simonoff, Adam J.	709/250
	J	US-6,438,592 B1	08-2002	Killian, Michael G.	709/224
	K	US-6,636,908 B1	10-2003	Winokur et al.	710/29
	L	US-6,678,824 B1	01-2004	Cannon et al.	713/200
*	M	US-6,691,067 B1	02-2004	Ding et al.	702/186

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MCCREESH ET AL.	
		Examiner Backhean Tiv	Art Unit 2151	Page 2 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,226,117 A	07-1993	Miklos, Sarka J.	715/853
	B	US-5,463,775 A	10-1995	DeWitt et al.	702/186
	C	US-5,654,905 A	08-1997	Mulholland et al.	702/186
	D	US-5,675,752 A	10-1997	Scott et al.	715/866
	E	US-5,951,700 A	09-1999	Klein, Dean A.	714/47
	F	US-5,949,975 A	09-1999	Batty et al.	709/213
	G	US-6,046,740 A	04-2000	LaRoche et al.	715/764
	H	US-6,158,044 A	12-2000	Tibbetts, John J.	717/100
	I	US-6,308,208 B1	10-2001	Jung et al.	709/224
	J	US-6,363,477 B1	03-2002	Fletcher et al.	713/151
	K	US-6,381,632 B1	04-2002	Lowell, Bonnie J.	709/203
	L	US-6,446,119 B1	09-2002	Olah et al.	709/224
*	M	US-6,668,244 B1	12-2003	Rourke et al.	704/275

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/696,177 MCCREESH ET AL.	
		Examiner	Art Unit	Page 3 of 4 Backhean Tiv 2151

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,590,550 A	05-1986	Eilert et al.	714/45
	B	US-4,982,404 A	01-1991	Hartman, John L.	714/55
	C	US-5,148,548 A	09-1992	Meche et al.	455/514
	D	US-5,237,684 A	08-1993	Record et al.	719/318
	E	US-5,717,604 A	02-1998	Wiggins, Christopher	709/229
	F	US-5,797,018 A	08-1998	Tavallaei et al.	710/200
	G	US-5,802,555 A	09-1998	Shigeeda, Akio	711/106
	H	US-5,809,250 A	09-1998	Kisor, Gregory Hurst	709/227
	I	US-5,862,335 A	01-1999	Welch et al.	709/224
	J	US-5,874,960 A	02-1999	Mairs et al.	715/733
	K	US-6,065,138 A	05-2000	Gould et al.	714/47
	L	US-6,601,058 B2	07-2003	Forster et al.	707/3
*	M	US-6,654,036 B1	11-2003	Jones, Steven Paul	715/798

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No. 09/696,177	Applicant(s)/Patent Under Reexamination MCCREESH ET AL.	
		Examiner Backhean Tiv	Art Unit 2151	Page 4 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
#	A	US-3,668,653 A	06-1972	Fair et al.	700/1
	B	US-4,802,116 A	01-1989	Ward et al.	703/23
	C	US-5,713,027 A	01-1998	Soejima et al.	713/300
	D	US-5,835,765 A	11-1998	Matsumoto, Hajime	718/102
	E	US-5,983,351 A	11-1999	Glogau, Jordan J.	713/201
	F	US-6,026,499 A	02-2000	Shirakihara et al.	714/11
	G	US-6,212,573 B1	04-2001	Lim et al.	719/315
	H	US-6,279,124 B1	08-2001	Brouwer et al.	714/38
	I	US-6,414,594 B1	07-2002	Guerlain, Stephanie Anne Elisabeth	340/506
	J	US-6,480,883 B1	11-2002	Tsutsumitake, Hideyuki	709/203
	K	US-6,732,167 B1	05-2004	Swartz et al.	709/223
	L	US-			
#	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.